## Notice of References Cited Application/Control No. 10/735,803 Examiner Phu Vu Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0054248	05-2002	Cheng et al.	349/54
*	В	US-6,628,368	09-2003	Yang, Jenn-Fang	349/192
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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